Search Notes	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/602,177	AGARWAL ET AL.
	Examiner	**Art Unit**
	Caixia Lu	1713

SEARCHED

Class	Subclass	Date	Examiner
526	336	5-25-05	CL
|	339	|	|
|	165	|	|

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
526	339	5-25-06	CL

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR

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